

## Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under
09/900,059	Reexamination HOEKMAN ET A	L
Examiner	Art Unit	
Neveen Abel-Jalil	2175	Page 1 of 1

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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.